Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	Applicant(s)/Patent under Reexamination	
10/056,368	VAN DER SCHAAR, MIHAEI	_A	
Examiner	Art Unit		
Annan Q. Shang	2623		

	SEAR	CHED	
Class	Subclass	Date	Examiner
725	87-104	8/9/2006	A.S
709	217-223	8/9/2006	A.S
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INT	INTERFERENCE SEARCHED		
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